Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10659820	PABLA ET AL.
Examiner	Art Unit
Park, Jeong S	2109

SEARCHED						
Class	Subclass	Date	Examiner			
709	224	3/8/2007	Jeong Park			
718	105	3/13/2007	Jeong Park			

SEARCH NOTES				
Search Notes	Date	Examiner		
limited text search of 718/102 with terms of "grid or distributed", "computing or compute"	3/13/2007	Jeong Park		
limited text search of 718/104 with terms of "grid or distributed", "computing or compute"	3/13/2007	Jeong Park		
limited text search of 718/105 with terms of "grid or distributed", "computing or compute"	3/13/2007	Jeong Park		
limited text search of 718/205, 226 with terms of "grid or distributed", "computing or compute"	3/13/2007	Jeong Park		
Updated search, see notes	4/3/2008	Jeong Park		

INTERFERENCE SEARCH						
Class	Subclass	Date	Examiner			

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